

• General Description

The AGM310MA combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{\text{DS}(\text{ON})}$.

This device is ideal for load switch and battery protection applications.

Features

- Advance high cell density Trench technology
- Low R_{DS(ON)} to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance
- 100% Avalanche tested
- 100% DVDS tested

Application

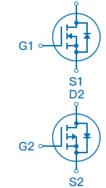
- MB/VGA Vcore
- SMPS 2nd Synchronous Rectifier
- POL application
- BLDC Motor driver

Product Summary

BVDSS	RDSON	ID
30V	11mΩ	23A
-30V	24mΩ	-18A

PDFN5*6 Pin Configuration





Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
AGM310MA	AGM310MA	PDFN5*6	330mm	12mm	3000

Table 1. Absolute Maximum Ratings (TA=25°C)

		Rat	ing		
Symbol	Parameter	N-Ch	P-Ch	Units	
V _{DS}	Drain-Source Voltage (V _{GS=} 0V)	30	-30	V	
V_{GS}	Gate-Source Voltage (V _{DS=} 0V)	±20	±20	V	
	Drain Current-Continuous(TC=25℃) (Note 1)	23	-18	Α	
I D	Drain Current-Continuous(TC=100°C)	16	-14	Α	
DM (pluse)	Drain Current-Pulsed (Note 2)	92	-72	А	
	Total Power Dissipation(TC=25℃)	28	28	W	
P_D	Total Power Dissipation(TC=100°C)	11	11	W	
EAS	Avalanche energy (Note 3)	64	64	mJ	
TJ,TSTG	Operating Junction and Storage Temperature Range	-55 To 150	-55 To 150	°C	

Table 2. Thermal Characteristic

Symbol	Parameter	Тур	Max	Unit
Reja	Thermal Resistance Junction-ambient (Steady State) ¹		20	°C/W
Rejc	Thermal Resistance Junction-Case ¹		4.4	°C/W



Table 3. N- Channel Electrical Characteristics (TJ=25℃unless otherwisenoted)						
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
On/Off Stat	es					
BVDSS	Drain-Source Breakdown Voltage	VGS=0V ID=250µA	30			V
IDSS	Zero Gate Voltage Drain Current	VDS=30V,VGS=0V			1	μΑ
IGSS	Gate-Body Leakage Current	VGS=±20V,VDS=0V			±100	nA
VGS(th)	Gate Threshold Voltage	VDS=VGS,ID=250µA	1.2	1.6	2.2	V
gFS	Forward Transconductance	VDS=5V,ID=5A		7		S
RDS(on)	Drain-Source On-State Resistance	VGS=10V, ID=10A		11	16	mΩ
T DO(OH)	Brain Godroc on Glate Registance	VGS=4.5V, ID=5A		15	25	mΩ
Dynamic (Characteristics					
Ciss	Input Capacitance	VDS=15V,VGS=0V,		850		pF
Coss	Output Capacitance	F=1MHZ		130		pF
Crss	Reverse Transfer Capacitance			88		pF
Rg	Gate resistance	VGS=0V, VDS=0V,f=1.0MHz		1.9		Ω
Switching	Times					
td(on)	Turn-on Delay Time			4.7		nS
tr	Turn-on Rise Time	VGS=10V,VDS=15V,		11		nS
td(off)	Turn-Off Delay Time	RL=0.75Ω,RGEN=6Ω		17		nS
tf	Turn-Off Fall Time			5.6		nS
Qg	Total Gate Charge			16		nC
Qgs	Gate-Source Charge	VGS=10V, VDS=15V, ID=10A		3		nC
Qgd	Gate-Drain Charge	_ ID-10/A		3.8		nC
Source-Dr	ain Diode Characteristics					
ISD	Source-Drain Current(Body Diode)				23	Α
VSD	Forward on Voltage	VGS=0V,IS=10A			1.2	V
trr	Reverse Recovery Time	IF=10A , dI/dt=100A/μs ,				ns
Qrr	Reverse Recovery Charge	TJ=25℃				nc

Notes 1. The maximum current rating is package limited.

Notes 2.Repetitive Rating: Pulse width limited by maximum junction temperature

Notes 3.EAS condition: TJ=25 $^{\circ}\text{C}$,VDD=15V,Vgs=10V,ID=16A,L=0.5mH,RG=25ohm



Table 3. P-Channel Electrical Characteristics (TJ=25℃unless otherwisenoted)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
On/Off Sta	tes					
BVDSS	Drain-Source Breakdown Voltage	VGS=0V ID=-250µA	-30			V
IDSS	Zero Gate Voltage Drain Current	VDS=-24V,VGS=0V			-1	μA
IGSS	Gate-Body Leakage Current	VGS=±20V,VDS=0V			±100	nA
VGS(th)	Gate Threshold Voltage	VDS=VGS,ID=-250μA	-1.2	-1.5	-2.2	V
gFS	Forward Transconductance	VDS=-10V,ID=-5A		7		S
RDS(on)	Drain-Source On-State Resistance	VGS=-10V, ID=-10A		24	30	mΩ
1100(011)		VGS=-4.5V, ID=-5A		28	38	mΩ
Dynamic C	haracteristics					
Ciss	Input Capacitance	VDS=-15V,VGS=0V,		860		pF
Coss	Output Capacitance	F=1MHZ		112		pF
Crss	Reverse Transfer Capacitance			98		pF
Rg	Gate resistance	VGS=0V, VDS=0V,f=1.0MHz		9		Ω
Switching	Times					
td(on)	Turn-on Delay Time			8.0		nS
tr	Turn-on Rise Time	VGS=-10V,VDS=-15V,		18		nS
td(off)	Turn-Off Delay Time	ID=-15A,RGEN=3.3Ω		31.8		nS
tf	Turn-Off Fall Time			18.4		nS
Qg	Total Gate Charge			12		nC
Qgs	Gate-Source Charge	VGS=-10V, VDS=-25V, ID=-12A		2.0		nC
Qgd	Gate-Drain Charge	VDS25V, ID12A		2.9		nC
Source-Dra	ain Diode Characteristics					1
ISD	Source-Drain Current(Body Diode)				-18	А
VSD	Forward on Voltage	VGS=0V,IS=-10A			-1.2	V
trr	Reverse Recovery Time	IF=-10A , dI/dt=100A/μs ,				ns
Qrr	Reverse Recovery Charge	TJ=25℃				nc

Notes 1. The maximum current rating is package limited.

 $Notes 2. Repetitive \ Rating: Pulse \ width \ limited \ by \ maximum junction \ temperature \ Notes$

3.EAS condition: TJ=25 $^{\circ}$ C,VDD=-15V,Vgs=-10V,ID=-16A, L=0.5mH,RG=25ohm



•N Channel characteristics curve

Fig.1 Power Dissipation Derating Curve

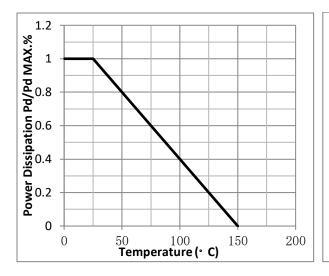


Fig.2 Typical output Characteristics

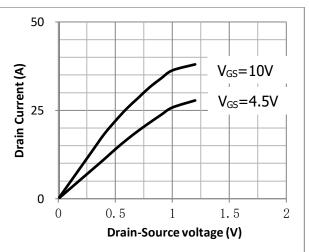


Fig.3 Threshold Voltage V.S Junction Temperature

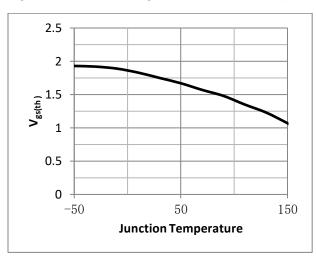


Fig.4 Resistance V.S Drain Current

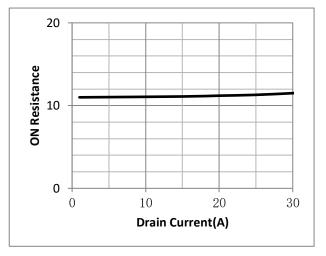


Fig.5 On-Resistance VS Gate Source Voltage

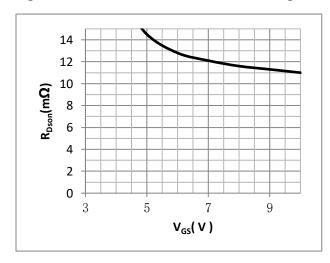
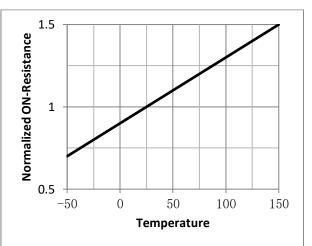


Fig.6 On-Resistance V.S Junction Temperature





•P Channel characteristics curve

Fig.1 Power Dissipation Derating Curve

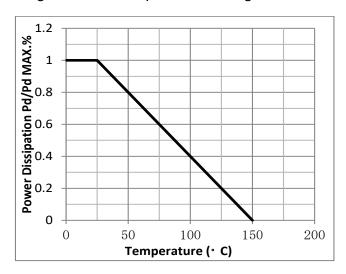


Fig.2 Typical output Characteristics

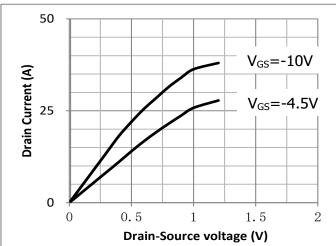
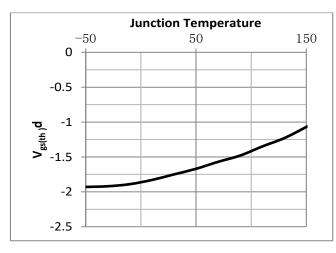


Fig.3 Threshold Voltage V.S Junction Temperature

Fig.4 Resistance V.S Drain Current



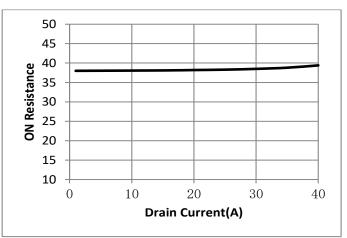


Fig.5 On-Resistance VS Gate Source Voltage

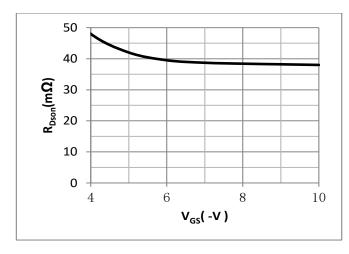
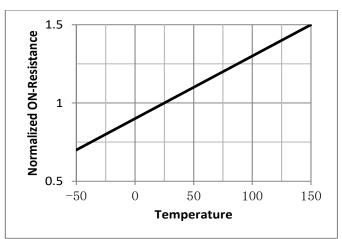


Fig.6 On-Resistance V.S Junction Temperature





Test Circuit

Fig.1 Switching Time Measurement Circuit

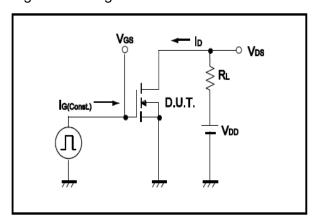


Fig.2 Gate Charge Waveform

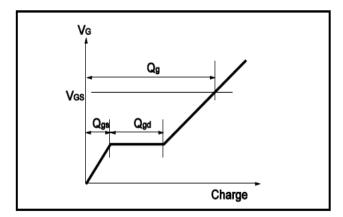


Fig.3 Switching Time Measurement Circuit

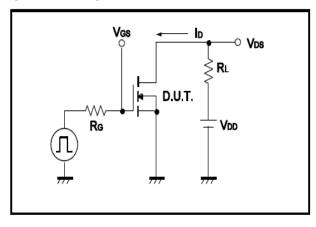


Fig.4 Gate Charge Waveform

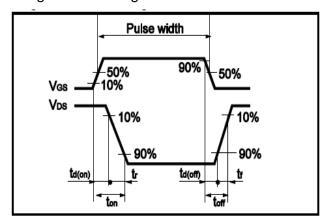


Fig.5 Avalanche Measurement Circuit

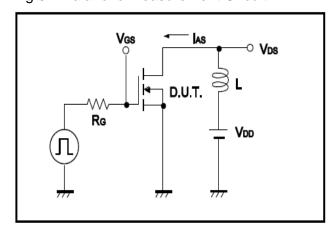
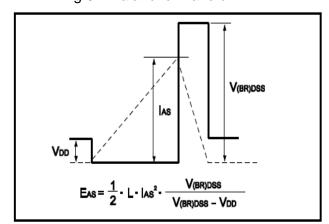
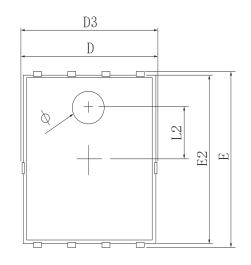


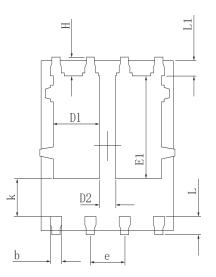
Fig.6 Avalanche Waveform

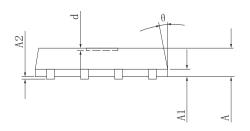




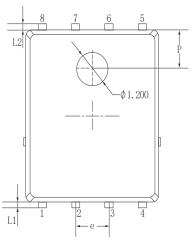
•Dimensions (PDFN5*6)

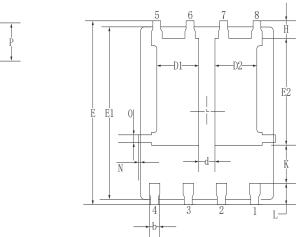






	ı		
SYMBOL		MILLIMETER	2
SIMDOL	MIN	Тур.	MAX
A	0.900	1.000	1.100
A1		0.254 REF.	
A2		0~0.05	
D	4. 824	4. 900	4. 976
D1	1.605	1.705	1.805
D2	0.500	0.600	0.700
D3	4. 924	5.000	5.076
Е	5. 924	6.000	6.076
E1	3. 375	3. 475	3. 575
E2	5. 674	5. 750	5. 826
b	0.350	0. 400	0.450
е		1.270 TYP.	
L	0.534	0.610	0.686
L1	0.424	0. 500	0.576
L2		1.800 REF.	
k	1.190	1. 290	1.390
Н	0.549	0. 625	0.701
θ	8°	10°	12°
Φ	1.100	1. 200	1.300
d			0.100





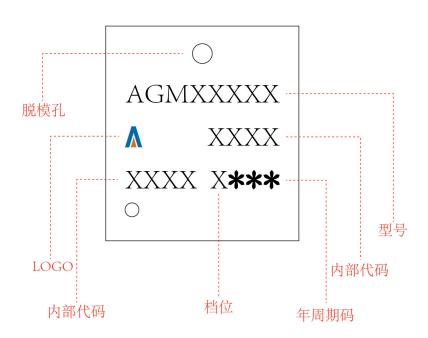
M		
		Ā
С		
	D—————————————————————————————————————	

	M	illitmeter	S
Symbol	MIN.	NOM.	MAX.
A	0.90	1.05	1.20
b	0.35	0.40	0.50
С	0.20	0.25	0.35
D	4.90	5. 05	5. 20
D1/D2	1.51	1.61	1.71
d	0.50	0.60	0.70
Е	6.00	6. 15	6.30
E1	5.60	5. 75	5. 90
E2	3.47	3. 57	3. 67
е		1. 27 BSC.	
Н	0.48	0. 58	0.68
K	1.17	1. 27	1. 37
L	0.64	0.74	0.84
L1/L2		0.20 REF.	
θ	8°	10°	12°
M	0.08 REF.		
N	0	-	0.15
0	0.25 REF.		
P	1.28 REF.		

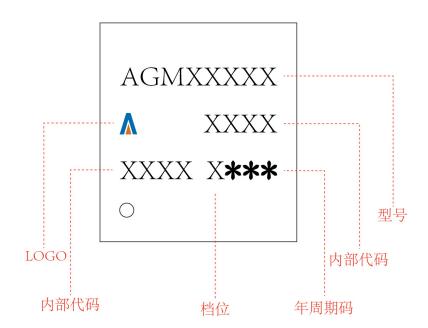


PDFN5*6 Marking Instructions:

Model1:



Model2:





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